IAP15 Rec d PCT/PTO 11 APR 2006 IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Junichi TANAKA et al.

Application No.: New U.S. National Stage of

PCT/JP2004/017078

Filed: April 11, 2006 Docket No.: 127648

For: METHOD AND DEVICE FOR EXAMINATION OF NONUNIFORMITY DEFECTS OF

PATTERNS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of one or more non-English language reference is discussed in the present specification. See Reference 2.
- 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See Reference 1.
- 4. An English language Abstract of one or more non-English language reference is attached hereto. See References 1-2.
- 5. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 1-2.

Respectfully submitted

Registration No. 27,075

William P. Berridge (Registration No. 30,024

JAO:WPB/jrb

Date: April 11, 2006

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				Junichi TANAKA et al.							
				FILING DATE April 11, 2006							
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Date: April 11, 2006